

Notice of References Cited	Application/Control No. 10/764,692		Applicant(s)/Patent Under Reexamination CHERITON, DAVID R.	
	Examiner AHMED ELALLAM		Art Unit 2616	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0146016 A1	10-2002	Liu et al.	370/401
*	B	US-2003/0112756 A1	06-2003	Le Gouriellec et al.	370/230
*	C	US-2003/0219022 A1	11-2003	Dillon et al.	370/395.52
*	D	US-6,675,225 B1	01-2004	Genty et al.	709/245
*	E	US-2004/0170173 A1	09-2004	Pan et al.	370/392
*	F	US-2005/0005024 A1	01-2005	Samuels et al.	709/238
*	G	US-6,977,932 B1	12-2005	Hauck, Scott	370/392
*	H	US-6,975,647 B2	12-2005	Neale et al.	370/466
*	I	US-2006/0062233 A1	03-2006	Brewer et al.	370/412
*	J	US-7,299,277 B1	11-2007	Moran et al.	709/224
*	K	US-6,487,689	11-2002	Chuah	714/748
*	L	US-6145032	11-2002	Bannister	710/52
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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